Acterna T-BERD® T-Carrier Analyzer

Total testing capability for the entire sp

Today's demanding network-testing environment calls for test instrumentation that is powerful, rugged, compact and easy to use. Ideal for testing from the central office, in the field, or at customers' premises, Acterna T-BERD Analyzers for T1 (Model 107A) and T3 (Model 307) testing meet these requirements and more. Each in the ment provides all the testing capabilities necessary for trouble shooting the entire network in a compact and highly portable battery-powered unit.

The T-BERDT1 Analyzer is a physical layer services tester that provides the ability to troubleshoot equipment and test the fullT1 span. Used during PDH circuit installation, acceptance testing, and fault isolation, the T1 Analyzer can transmit and receive test patterns during out-of-service circuit testing. The T1 Analyzer also monitors a T1 circuit without interrupting revenuegenerating service.

010 The T-BERD T3 Analyzer designed and pov sivelv test d comtechnologies including ons, video conint uted data processing, tion based graphics. S1/DSØ zignals can also be tested ng DS3 circuits. The T-BERD Kyzer fully tests DS3 and DS1 cuits simply and easily with autoatic configuration and setup to save time and money.

Product summary

Both Acterna T-BERD instruments can transmit and receive preprogrammed, long user-patterns including 55 OCTET and T1 DALY, allowing circuits to be tested to the maximum. With its powerful emulation of both the customer premises service unit (CSU) and network interface unit (NIU) from the span, companies can isolate the toughest problems and simplify troubleshooting. When troubleshooting DS0 problems users can also listen to individual VF channels and monitor data and ABCD signaling bits on all 24 channels. The channel monitor feature also

Highlights

- Test complex digital transmission networks rapidly and economically
- Identify network synchronization problems quickly
- Combine convenience and power with these rugged yet lightweight test instruments
- Reduce setup time with automatic configuration



This instrument is ideal for full installation and maintenance testing along T-Carrier spans

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T-BERD T1 Analyzer (107A)

The T-BERD T1 Analyzer's comprehensive capabilities help save considerable time at every stage of the installation and test process. Error and signal analysis can be performed at any point along a T1 span. This instrument is ideal for full installation and maintenance testing along T-Carrier spans.

option enables the technician to isolate problems anywhere along the network with minimal circuit downtime. It can use intelligen repeater technology in the field qualify and maintain circul intrusively query per Span problems can b remotely before dis maintenance n@tlmeis saved with & d Furth mated test terns that elin pina the need ans can be bof a button nd ar ed BRIDGTAP and sts developed by Acterna.

Downtime is also minimized. The

Smart Loopback/Command Codes



figure 1

Rx

T-BERD 107A

NIST, ISO, IEC, ANSI, NCSL, MIL-STD by www.raeservices.com

Applications

The T-BERD T1 Analyzer is ideal for T1 turn-up and maintenance. It makes it possible to troubleshoot and isolate physical layer problems, measure VF level, frequency, and quality with the channel monitor feature. Network synchronization problems are also isolated easily.

Monitor live T1 networks

The instrument determines framing, coding, and pattern automatically. It can also detect errors for instant display on the front panel. Signal quality and data bits can be monitored on any DS0 channel. Decode the SLC data link or ESF signal and monitor signaling bits to troubleshoot problems in the field (see figure 1).

Qualify T-Carrier circuits

Utilize preprogrammed loop codes for intelligent repeaters to sectionalize span problems before dispatching maintenance personnel. Loop NIUs and CSUs from the central office with one test instrument. Perform automated pattern tests to test the span and identify problems rapidly (see figure 2 below).

Isolate network synchronization problems

Verify Fractional T1 Service

to verify transmission quality contiguous and noncontiguous

bandwidths

DS0 chang

Sont Property Cont

Use the Fractional T1 option to perform bit error rate tests on Sale and channels

KFtone

Network Interface Unit

Timing problems are identified easily. Compare a T1 circuit with a network reference clock to isolate timing slips (see figure 3 below).

Decode ESF Signal

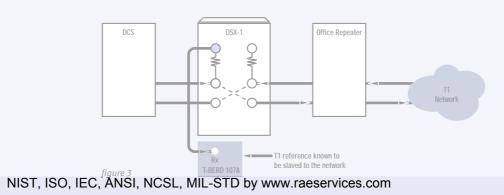
Verify remote in-service circuit performance from the decoded ESF broadcast and access performance statistics by monitoring NIUs with the Enhanced ESF option.

Decode SLC® Datalinks

Decode alarms and datalink messages when installing and troubleshooting SLC systems with the SLC Decode option.



T1 MUX



CSU

T-BERD T3 Analyzer (307)

The Acterna T-BERD T3 Analyzer delivers powerful features that speed testing from a versatile, lightweight battery-powered instrument that is ideal for field service technicians. Unmatched flexibility means tests can be carried out from a variety of access points. Users can verify tributaries at DS3 access points or use the instrument as a DS1 test instrument.

Timing errors are identified rapidly and the DS1 timing reference can be accessed from either DS3 or DS1 access points.

Applications

Multiplexed DS3 patterns

The instrument can simulate 3:1 multiplexers or cross-connects for DS3 and DS1 circuit qualification. Test tones, patterns, loop codes or errors on one or all DS1 channels. For additional testing flexibility DS1 channels can be dropped from the received DS3 signal for analysis (see figure 4 below).

Isolate network synchronization problems

Timing problems are identified rapidly, particularly timing impairments, a common source of errors in asynchronous and synchronous networks. Compare a T1 circuit against a network reference clock to isolate timing slips (see figure 5 below).

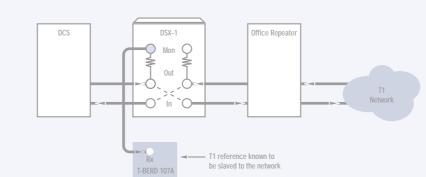
Test far-end equipment with ease Automatically loop up the far-end equipment and verify if data is being received properly on specified DS1 channels by transmitting C-bit FEAC or DS1 loop codes. Results and alarms are immediately visible of the front panel.





M13

MUX



M13

MUX

DS1 Loopback

DSX-3 Mon

In -

C

	Technical specifications		Electrical/Mechanical specifications						
	T-BERD T1 Analyzer (107a)		Size (H x W x D)	8.5 x 4.25 x 3.25 in					
	Operating modes			(21.6 x 10.8 x 8.3 cm)					
	Self Test, Automatic Configura	tion, T1, T1 D4, T1	Weight	4.5 lb (2.1 kg)					
	ESF, T1 SLC, SLC-M1*, SLC-M2		Operating temperature	32°F to 122°F					
	Framed*, FT1 ESF Framed*, T			(0°C to 50°C)					
	Line Loopback, SMARTNIU*, T1	MBLT	Storage Temperature	-40°F to 167°F					
	<i>Patterns</i> All Ones, 1:1, 1:7, 2 IN 8, 3 IN 24, T1-QRSS,			(-40°C to 75°C)					
				Adapter: 120 VAC to 12 VDC					
	BRIDGTAP, MULTIPAT, User 1, L	lser 2, User 3, All	Charging time	8 hours (nominal)					
	Zeros, 404 Hz*, 1004 Hz*, 280)4 Hz*, 2713 Hz*, T1	5	12 VDC, lead-acid electrolyte					
	DALY*, T1-2/96*, T1-3/54*, T	I-4/120*, T1-5/53*,	Operation	4 hours (nominal)					
	55 OCTET*, MIN/MAX*		JARRA 13 Analyzer (30)7)					
	Input and output connectors		Operating modes						
	Bantam and RS-232 (printer o	peration)	Allafragod M13 Muyed	M12 C Bit Muyod C Bit					
	Input impedance		(Unfranced, M13, Muxer N13, C-Bit, Muxed C-Bit, DS Unsert, Set Test, Automatic Configuration						
		/ or greater with ArBO	Patterns	Romatic Configuration					
		$\Omega \Omega \pm 5\%$ with ALBO		-1, All Ones, Idle, AIS1010,					
	DSX-MON Receive level	100 Ω ±5% with ASC <							
	BRIDGE or TERM		35 dBdsx Input and output connectors istre loss) WEO 560A jack Receive frequency						
	Output level	Ash (Upresistive 1033)							
	736 000 Hz + 300ppm								
	Isolated 11 pulse is 350 volts Peak ±0.6 V at 0 dBdsx (conforms with AttSI FH102-1993 and ITU-T G.703-1998) <i>LBO level</i> Line Build Out (LBO) of 7.5, 15.0 and 22.5 dB measured in \$3 kH2±1 kHz band centered at 7/2 kHz		Input impedance 75 ohms ±5%, unbalanced to ground Transmitter frequency 44.736 Mb/s ±5ppm Transmit timing sources Internal Clock, Recovered Clock						
					$\$ LB(tolerance 2 dBat	5, 15.0, and 22.5 dB	Line codes		
					Where (7)		B3ZS		
							Electrical/Mechanical specifications		
						Resolution	0.1 dB ±0.5 dBm	Size (H x W x D)	8.5 x 4.24 x 3.25 in
					~~~~	VF frequency	±0.5 ubiii		(21.6 x 10.8 x 8.3 cm)
	~~ C	Rappe 60 to 3904 Hz	: (+3.0 to –26.0 dBm)	Weight	4.2 lb (1.9 kg)				
	$\land \land \land \land \land$		(-26.0 to -40.0 dBm)	Operating Temperature	32°F to 122°F				
	()	Resolution	1 Hz		(0°C to 50°C)				
	Accuracy	±1 Hz	Storage Temperature	-40°F to 167°F					
	Vransmit timing sources			(-40°C to 75°C)					
	Vinternal Clock, Recovered Cloc	k, External Clock							
$\sim 102$	Loopback codes								
	CSU, CSU Line (ESF), CSU Pay	load (ESF),							
$(\bigcirc)$	NIU (FAC1, FAC2, FAC3), NIU N	etwork (ESF),							
	programmable (3 to 8 bit), int	elligent repeaters							
$\langle \hat{z} \rangle$	Line codes								
	AMI, B8ZS								
-									

T-BERD T1 An	alyzer (107A)		
Model no.	Description		
107A	T-BERD T-Carrier Analyzer		
107A-P1	T-BERD T-Carrier Analyzer		
with 107	7A-1, 107A-2, 107A-3, 107A-4, 107A-5		
Includes			
Soft carrying of	case		
AC adapter/ch	narger		
Printer cable			
Model no.	Description		
107A-1	SLC Decode		
107A-2	Advanced Stress Patterns		
107A-3	Enhanced ESF		
107A-3			
107A-4	Smart Loopback/Command Codes		

T-BERD DS3 Communications Analy

T-BERD T3 Analyzer (307)

Model no.

Options *Model no.* 

307-1

307

Acterna offers a three-year warranty on all mainframes and options and includes repair and has calibration facilities worldwide. We also provide extended warranty options. As part of our ISO9001approved quality system, our components are screened before installation and all instruments are operated at elevated temperatures and vibration levels before being shipped.

#### Technical support

Description

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DS1 Ana

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Warranty and repair service

To complement our instruments and systems, Acterna provides superior technical support. Our TAC engineers offer expert consultation on any technical problem from any to 8 pm Monday through Friday EST (1886-ACTER)

Training The tight technical training makes everyone more productive and every test instrument more everyor. Whener your goal is to shorten installation time, reduce downtime or increase productivity technologies instructors provide practical, hands-or (tangin) tailored to your specific needs. We can provide training at our facility (in Maryland, USA or any location you designate.

Acterna is the world's largest provider of test and management solutions for optical transport, access and cable networks, and the second largest communications test company overall. Focused entirely on providing equipment, software, systems and services, Acterna helps customers develop, install, manufacture and maintain optical transport, access, cable, data/IP and wireless networks.

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